

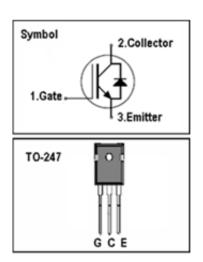
IGBT

Features

- 650V,40A
- $V_{CE(sat)(typ.)}$ =2.0V@ V_{GE} =15V, I_{C} =40A
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA

General Description

JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as Motor control, general inverter and other soft switching applications.



Absolute Maximum Ratings

| Symbol | ol Parameter Value | | Units | |
|------------------|--|---------------|------------|--|
| Vces | Collector-Emitter Voltage | 650 | | |
| V _{GES} | Gate-Emitter Voltage | <u>+</u> 30 V | | |
| | Continuous Collector Current (Tc=25 °C) | 80 | Α | |
| lc | Continuous Collector Current (Tc=100°C) | 40 | А | |
| Ісм | Pulsed Collector Current (Note 1) 120 | | Α | |
| I _F | Diode Continuous Forward Current (T _C =100 °C) | 40 | А | |
| I _{FM} | Diode Maximum Forward Current (Note 1) | 120 | А | |
| t _{sc} | Short Circuit Withstand Time | 10 | us | |
| Б | Maximum Power Dissipation (T _C =25 °C) | 278 | W | |
| P _D | Maximum Power Dissipation (T _C =100 °C) | 111 | W | |
| TJ | Operating Junction Temperature Range | -55 to +150 | $^{\circ}$ | |
| T _{STG} | Storage Temperature Range | -55 to +150 | $^{\circ}$ | |

Thermal Characteristics

| Symbol Parameter Max. | | Units | |
|-----------------------|---|-------|--------------|
| R _{th j-c} | Thermal Resistance, Junction to case for IGBT | 0.45 | °C/ W |
| R _{th j-c} | R _{th j-c} Thermal Resistance, Junction to case for Diode 1.5 °C/W | | °C/W |
| R _{th j-a} | R _{th j-a} Thermal Resistance, Junction to Ambient 40 °C | | °C/W |



Electrical Characteristics (Tc=25 °C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|----------------------|--------------------------------------|---|------|------|------|-------|
| BV _{CES} | Collector-Emitter Breakdown Voltage | V_{GE} = 0V, I_{C} = 250uA | 650 | - | - | V |
| I _{CES} | Collector-Emitter Leakage Current | V _{CE} = 650V, V _{GE} = 0V | - | - | 100 | uA |
| I _{GES} | Gate Leakage Current, Forward | V_{GE} = ±20 V, V_{CE} = 0 V | - | - | ±100 | nA |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{GE} = V_{CE}$, $I_{C} = 250uA$ | 5.1 | - | 6.9 | V |
| V _{CE(sat)} | Collector-Emitter Saturation Voltage | V _{GE} =15V, I _C = 40A | - | 2.0 | 2.5 | V |
| Qg | Total Gate Charge | Vcc=480V | - | 594 | | nC |
| Qge | Gate-Emitter Charge | V _{GE} =15V | - | 119 | | nC |
| Qgc | Gate-Collector Charge | Ic=40A | - | 374 | | nC |
| t d(on) | Turn-on Delay Time | Vcc=400V | - | 19 | - | ns |
| t r | Turn-on Rise Time | | - | 65 | - | ns |
| t d(off) | Turn-off Delay Time | V _{GE} =15V | - | 86 | - | ns |
| t f | Turn-off Fall Time | ∃l _C =40A _R _G =15Ω | - | 98 | - | ns |
| Eon | Turn-on Switching Loss | Inductive Load | - | 1.3 | - | mJ |
| Eoff | Turn-off Switching Loss | T _C =25 ℃ | - | 0.5 | - | mJ |
| Ets | Total Switching Loss | | - | 1.8 | - | mJ |
| C _{ies} | Input Capacitance | - V _{CE} =25V V _{GE} =0V | - | 1340 | - | pF |
| Coes | Output Capacitance | | - | 98 | - | pF |
| C _{res} | Reverse Transfer Capacitance | f = 1MHz | - | 11.8 | - | pF |

Electrical Characteristics of Diode (Tc=25°C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|------------------|-------------------------------------|------------------------|------|------|------|-------|
| V _F | Diode Forward Voltage | I _F =40A | - | 1.5 | 3.0 | V |
| trr | Diode Reverse Recovery Time | V _{CE} = 400V | - | 148 | | ns |
| Irr | Diode peak Reverse Recovery Current | I _F = 40A | - | 13.8 | | Α |
| Q _{r r} | Diode Reverse Recovery Charge | Rg=15 Ω | - | 1055 | | nC |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



Typical Performance Characteristics

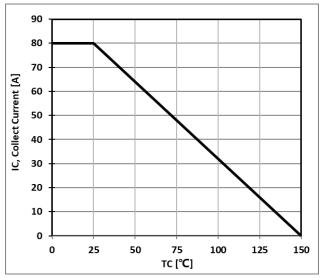


Figure 1: Maximum DC Collector Current VS. case temprature

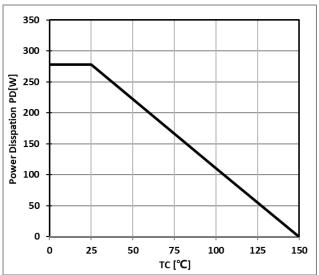


Figure 2: Power Dissipation VS. Case Temperature

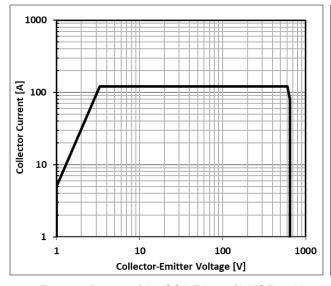


Figure 3: Reverse Bias SOA,TJ=125℃,VGE=15V

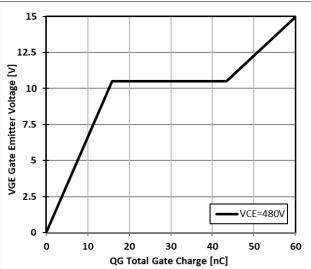


Figure 4: Typical Gate charge VS. VGE,IC=40A



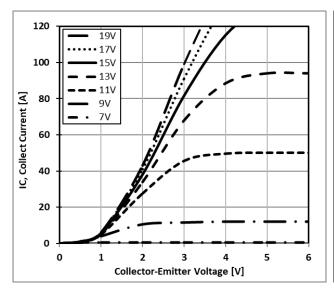


Figure 5: Typical IGBT Output characteristics, $TC=25^{\circ}C$;tp=300us

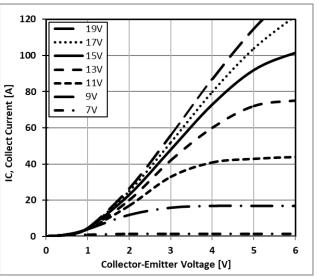


Figure 6: Typical IGBT Output characteristics, TC=150°C;tp=300us

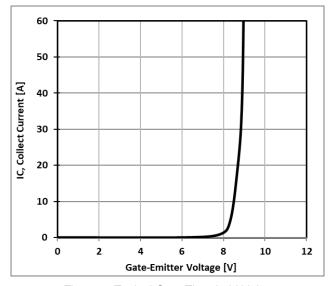


Figure 7: Typical Gate Threshold Voltage

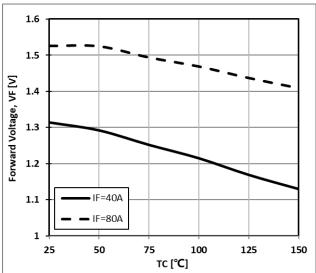


Figure 8: Typical Forward Voltage vs IF



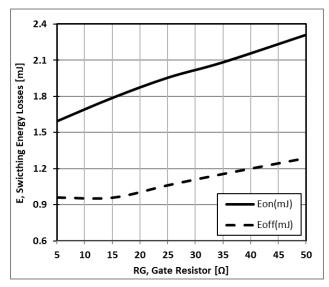


Figure 9: Typical Energy Loss VS. RG, TC=25 °C, L=200uH,VCE=400V,VGE=15V,IC=40A

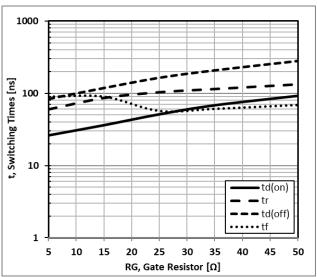


Figure 10: Typical Switching Time VS. RG, TC=25°C, L=200uH,VCE=400V,VGE=15V,IC=40A

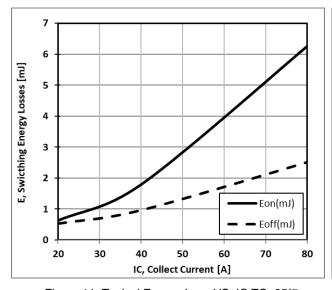


Figure 11: Typical Energy Loss VS. IC,TC=25 $^{\circ}$ C, L=200uH, VCE=400V, VGE=15V,RG=15 $^{\Omega}$

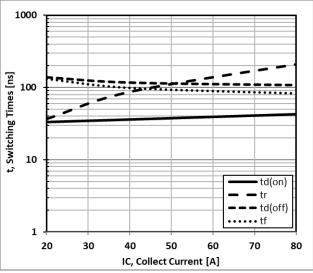


Figure 12: Typical Switching Time VS. IC,TC=25 $^{\circ}$ C, L=200uH,VCE=400V,VGE=15V,RG=15 $^{\circ}$



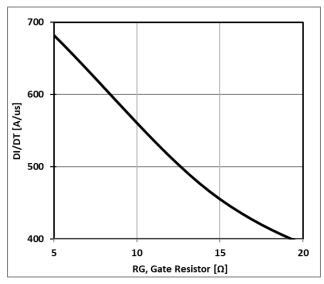


Figure 13: Typical Diode DI/DT VS. RG,TC=25°C VCC=400V, VGE=15V, IF=40A

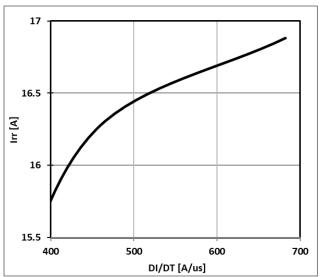


Figure 14: Typical Diode IRR VS. DI/DT,TC=25°C VCC=400V,VGE=15V, IF=40A

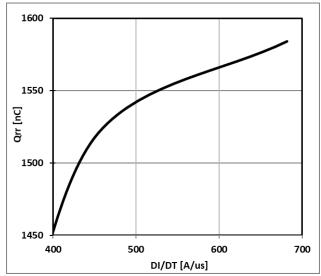


Figure 15: Typical Diode Qrr VS. DI/DT,TC=25℃ VCC=400V, VGE=15V, IF=40A

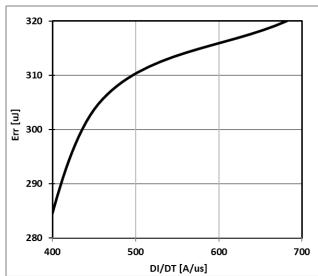
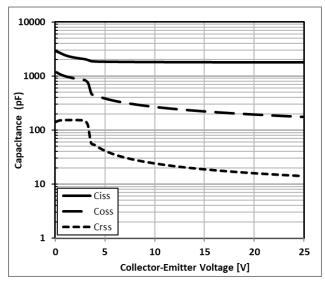
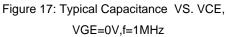


Figure 16: Typical Diode Err VS. DI/DT,TC=25 $^{\circ}$ C VCC=400V, VGE=15V, IF=40A







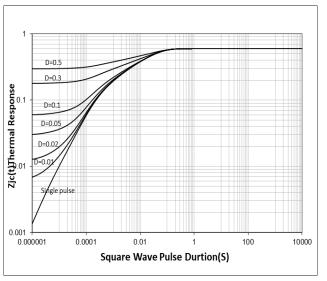
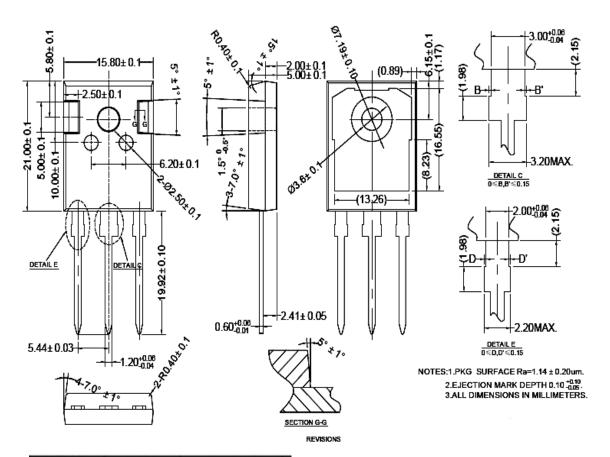


Figure 18: Normalized transient thermal impedance junction-to-case



TO-247 PACKAGE OUTLINE



| 公差标注 | 公差值 | 表面粗糙度 |
|--------|--------|-----------|
| 0 | ±0.2 | Ra3.2~6.3 |
| 0.0 | ±0.1 | Ra1.6~3.2 |
| 0.00 | ±0.01 | Ra0.8~1.6 |
| 0.000 | ±0.005 | Ra0.4~0.8 |
| 0.0000 | ±0.002 | Ra0.2~0.4 |

0≤D,D'≤0.15

NOTES:1.PKG SURFACE Ra=1.14 ± 0.20um. 2.EJECTION MARK DEPTH 0.10 ±0.05 3.ALL DIMENSIONS IN MILLIMETERS.



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